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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,640	BAZAN ET AL.	
Examiner	Art Unit	
Minh N. Tang	2829	•

Minh N. Tang

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	ce Search Printout	10/26/2005	MT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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